

1. Record Nr.	UNINA9910999673503321
Titolo	Image Processing, Computer Vision, and Pattern Recognition and Information and Knowledge Engineering : 28th International Conference, IPCV 2024, and 23rd International Conference, IKE 2024, Held as Part of the World Congress in Computer Science, Computer Engineering and Applied Computing, CSCE 2024, Las Vegas, NV, USA, July 22–25, 2024, Revised Selected Papers / edited by Leonidas Deligiannidis, Farid Ghareh Mohammadi, Farzan Shenavarmasouleh, Soheyla Amirian, Hamid R. Arabnia
Pubbl/distr/stampa	Cham : , : Springer Nature Switzerland : , : Imprint : Springer, , 2025
ISBN	3-031-85933-2
Edizione	[1st ed. 2025.]
Descrizione fisica	1 online resource (XVII, 386 p. 169 illus., 133 illus. in color.)
Collana	Communications in Computer and Information Science, , 1865-0937 ; ; 2262
Disciplina	005.8
Soggetti	Data protection Software engineering Image processing - Digital techniques Computer vision Artificial intelligence Computer science Data and Information Security Software Engineering Computer Imaging, Vision, Pattern Recognition and Graphics Artificial Intelligence Computer Science
Lingua di pubblicazione	Inglese
Formato	Materiale a stampa
Livello bibliografico	Monografia
Nota di contenuto	Image processing, computer vision and pattern recognition -- image processing, computer vision and pattern recognition - detection methods -- information and knowledge engineering.
Sommario/riassunto	This book constitutes the proceedings of the 28th International Conference on Image Processing, Computer Vision, and Pattern

Recognition, IPCV 2024, and the 23rd International Conference on Information and Knowledge Engineering, IKE 2024, held as part of the 2024 World Congress in Computer Science, Computer Engineering and Applied Computing, in Las Vegas, USA, during July 22 to July 25, 2024. The 19 IPCV 2024 papers included in these proceedings were carefully reviewed and selected from 98 submissions. IKE 2024 received 40 submissions and accepted 10 papers for inclusion in the proceedings. The papers have been organized in topical sections as follows: Image processing, computer vision and pattern recognition; image processing, computer vision and pattern recognition - detection methods; and information and knowledge engineering. .

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